NXP Semiconductors
Technical Data

Document Number: MRFX600H
Rev. 0, 09/2018

RF Power LDMOS Transistors

High Ruggedness N-Channel Enhancement-Mode Lateral MOSFETs

These high ruggedness devices are designed for use in high VSWR industrial, medical, broadcast, aerospace and mobile radio applications. Their unmatched input and output design supports frequency use from 1.8 to 400 MHz.

MRFX600H
MRFX600HS
MRFX600GS

1.8–400 MHz, 600 W CW, 65 V
WIDEBAND
RF POWER LDMOS TRANSISTORS

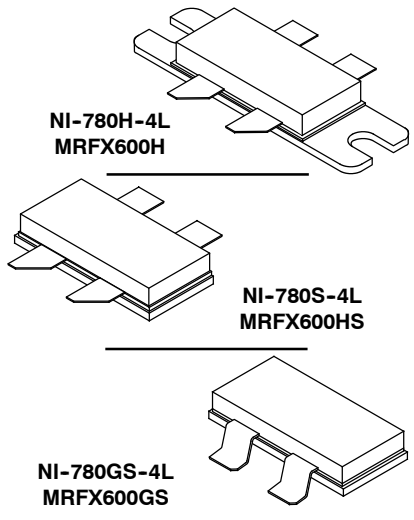
Typical Performance

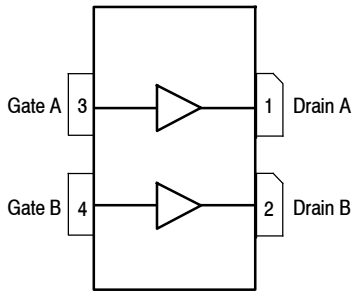
Frequency (MHz)	Signal Type	V_{DD} (V)	P_{out} (W)	G_{ps} (dB)	η_D (%)
87.5–108 (1,2)	CW	62	680 CW	21.3	83.0
230 (3)	Pulse (100 μsec, 20% Duty Cycle)	65	600 Peak	26.4	74.4

Load Mismatch/Ruggedness

Frequency (MHz)	Signal Type	VSWR	P_{in} (W)	Test Voltage	Result
230 (3)	Pulse (100 μsec, 20% Duty Cycle)	> 65:1 at all Phase Angles	2.5 Peak (3 dB Overdrive)	65	No Device Degradation

1. Measured in 87.5–108 MHz broadband reference circuit (page 5).
2. The values shown are the center band performance numbers across the indicated frequency range.
3. Measured in 230 MHz production test fixture (page 10).





(Top View)

Note: The backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections

Features

- Unmatched input and output allowing wide frequency range utilization
- Output impedance fits a 4:1 transformer
- Device can be used single-ended or in a push-pull configuration
- Qualified up to a maximum of 65 V_{DD} operation
- Characterized from 30 to 65 V for extended power range
- High breakdown voltage for enhanced reliability
- Suitable for linear application with appropriate biasing
- Integrated ESD protection with greater negative gate-source voltage range for improved Class C operation
- Included in NXP product longevity program with assured supply for a minimum of 15 years after launch

Typical Applications

- Industrial, scientific, medical (ISM)
  - Laser generation
  - Plasma generation
  - Particle accelerators
  - MRI, RF ablation and skin treatment
  - Industrial heating, welding and drying systems
- Radio and VHF TV broadcast
- Aerospace
  - HF communications
  - Radar
- Mobile radio
  - HF and VHF communications
  - PMR base stations

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Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	–0.5, +179	Vdc
Gate-Source Voltage	V_{GS}	–6.0, +10	Vdc
Storage Temperature Range	T_{stg}	–65 to +150	°C
Case Operating Temperature Range	T_C	–40 to +150	°C
Operating Junction Temperature Range (1,2)	T_J	–40 to +225	°C
Total Device Dissipation @ T_C = 25°C Derate above 25°C	P_D	1333 6.67	W W/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case CW: Case Temperature 75°C, 650 W CW, 62 Vdc, $I_{DQ(A+B)}$ = 250 mA, 98 MHz	$R_{\theta JC}$	0.15	°C/W
Thermal Impedance, Junction to Case Pulse: Case Temperature 73°C, 600 W Peak, 100 μsec Pulse Width, 20% Duty Cycle, 65 Vdc, $I_{DQ(A+B)}$ = 100 mA, 230 MHz	$Z_{\theta JC}$	0.037	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JS-001-2017)	Class 2, passes 2500 V
Charge Device Model (per JS-002-2014)	Class C3, passes 1000 V

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics (4)					
Gate-Source Leakage Current (V_{GS} = 5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	1	μAdc
Drain-Source Breakdown Voltage (V_{GS} = 0 Vdc, I_D = 100 mAdc)	$V_{(BR)DSS}$	179	193	—	Vdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 179 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	100	μAdc
On Characteristics					
Gate Threshold Voltage (4) (V_{DS} = 10 Vdc, I_D = 277 μAdc)	$V_{GS(th)}$	2.1	2.5	2.9	Vdc
Gate Quiescent Voltage (V_{DD} = 65 Vdc, I_D = 100 mAdc, Measured in Functional Test)	$V_{GS(Q)}$	2.7	2.9	3.2	Vdc
Drain-Source On-Voltage (4) (V_{GS} = 10 Vdc, I_D = 0.74 Adc)	$V_{DS(on)}$	—	0.2	—	Vdc
Forward Transconductance (4) (V_{DS} = 10 Vdc, I_D = 32 Adc)	g_{fs}	—	33.6	—	S

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at http://www.nxp.com/RF/calculators.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.nxp.com/RF and search for AN1955.
4. Each side of device measured separately.

(continued)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Dynamic Characteristics (1)					
Reverse Transfer Capacitance (V_{DS} = 65 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{rss}	—	1.1	—	pF
Output Capacitance (V_{DS} = 65 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{oss}	—	84	—	pF
Input Capacitance (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc ± 30 mV(rms)ac @ 1 MHz)	C_{iss}	—	299	—	pF
Functional Tests (2) (In NXP Production Test Fixture, 50 ohm system) V_{DD} = 65 Vdc, $I_{DQ(A+B)}$ = 100 mA, P_{out} = 600 W Peak (120 W Avg.), f = 230 MHz, 100 μsec Pulse Width, 20% Duty Cycle					
Power Gain	G_{ps}	24.5	26.4	27.5	dB
Drain Efficiency	η_D	71.0	74.4	—	%
Input Return Loss	IRL	—	–23	–12	dB

Table 5. Load Mismatch/Ruggedness (In NXP Production Test Fixture, 50 ohm system) $I_{DQ(A+B)}$ = 100 mA

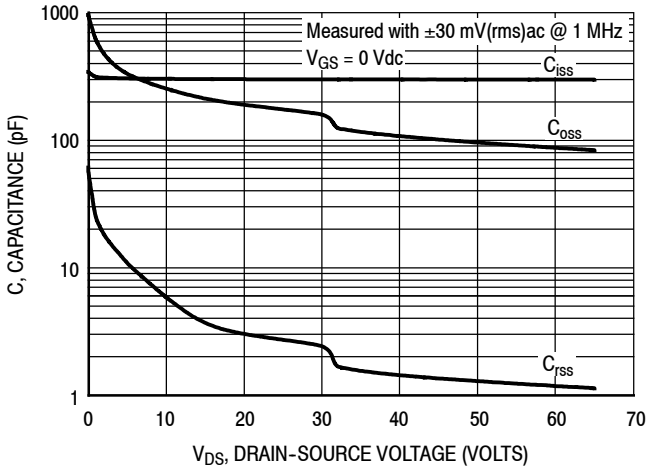
Frequency (MHz)	Signal Type	VSWR	P_{in} (W)	Test Voltage, V_{DD}	Result
230	Pulse (100 μsec, 20% Duty Cycle)	> 65:1 at all Phase Angles	2.5 Peak (3 dB Overdrive)	65	No Device Degradation

Table 6. Ordering Information

Device	Tape and Reel Information	Package
MRFX600HR5	R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel	NI-780H-4L
MRFX600HSR5	R5 Suffix = 50 Units, 32 mm Tape Width, 13-inch Reel	NI-780S-4L
MRFX600GSR5		NI-780GS-4L

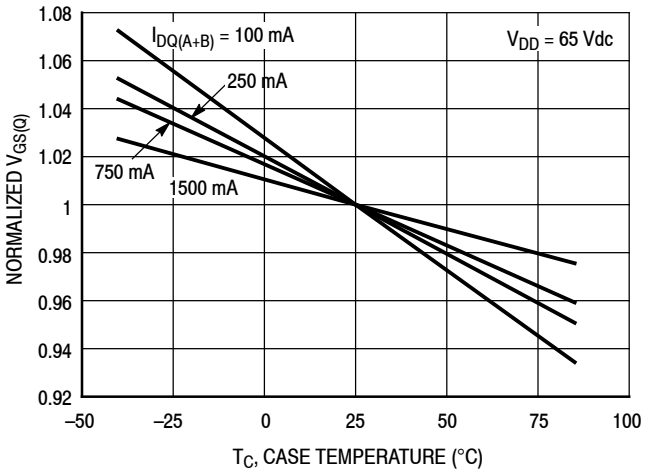
1. Each side of device measured separately.
2. Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GS) parts.

TYPICAL CHARACTERISTICS



Note: Each side of device measured separately.

Figure 2. Capacitance versus Drain-Source Voltage



I_{DQ} (mA)	Slope (mV/°C)
100	–3.20
250	–2.48
750	–2.16
1500	–1.36

Figure 3. Normalized V_{GS} versus Quiescent Current and Case Temperature

87.5–108 MHz BROADBAND REFERENCE CIRCUIT – 2.9″ × 4.7″ (7.3 cm × 12.0 cm)

Table 7. 87.5–108 MHz Broadband Performance (In NXP Reference Circuit, 50 ohm system)
$I_{DQ(A+B)}$ = 250 mA, P_{in} = 5 W, CW

Frequency (MHz)	V_{DD} (V)	P_{out} (W)	G_{ps} (dB)	η_D (%)
87.5	62	705	21.5	80.0
98	62	680	21.3	83.0
108	62	650	21.2	82.5

87.5–108 MHz BROADBAND REFERENCE CIRCUIT — 2.9″ × 4.7″ (7.3 cm × 12 cm)

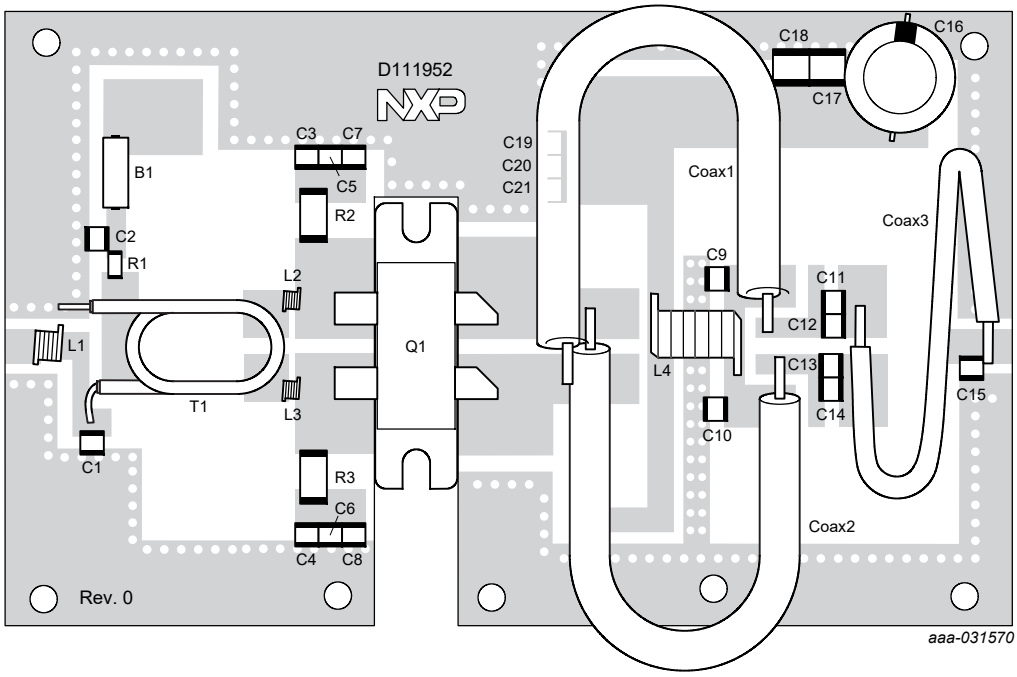


Figure 4. MRFX600H 87.5–108 MHz Broadband Reference Circuit Component Layout

Table 8. MRFX600H 87.5–108 MHz Broadband Reference Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1	Long Ferrite Bead	2743021447	Fair-Rite
C1	30 pF Chip Capacitor	ATC100B300JT500XT	ATC
C2, C5, C6, C9, C10, C11, C12, C13, C14	1000 pF Chip Capacitor	ATC100B102JT50XT	ATC
C3, C4	10,000 pF Chip Capacitor	ATC200B103KT50XT	ATC
C7, C8	470 pF Chip Capacitor	ATC100B471JT200XT	ATC
C15	1.0 pF Chip Capacitor	ATC100B1R0BT500XT	ATC
C16	470 μF, 63 V Electrolytic Capacitor	MCGPR63V477M13X26	Multicomp
C17, C18	10 μF Chip Capacitor	C5750X7S2A106M	TDK
C19	470 nF Chip Capacitor	GRM31MR72A474KA35L	Murata
C20	47 nF Chip Capacitor	GRM31MR72A473KA01L	Murata
C21	15 nF Chip Capacitor	C3225CH2A153JT	TDK
Coax1,2	35 Ω Flex Cable, 4.5″ Shield Length	HSF-141C-35	Hongsen Cable
Coax3	50 Ω Flex Cable, 6.3″ Shield Length	SM141	Huber + Suhner
L1	100 nH Inductor	1812SMS-R10JLC	Coilcraft
L2, L3	8.0 nH, 3 Turn Inductor	A03TJLC	Coilcraft
L4	5 Turn, #16 AWG, ID = 0.315″ Inductor	Handwound	NXP
Q1	RF Power LDMOS Transistor	MRFX600H	NXP
R1	10 Ω, 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
R2, R3	33 Ω, 2 W Chip Resistor	352133RFT	TE Connectivity
T1	2–300 MHz, 3 Turns, 9:1 Impedance Ratio Transformer	TUI-LF-9	Communication Concepts
PCB	Rogers RO4350B, 0.030″, ε_r = 3.66	D111952	MTL

TYPICAL CHARACTERISTICS – 87.5–108 MHz BROADBAND REFERENCE CIRCUIT

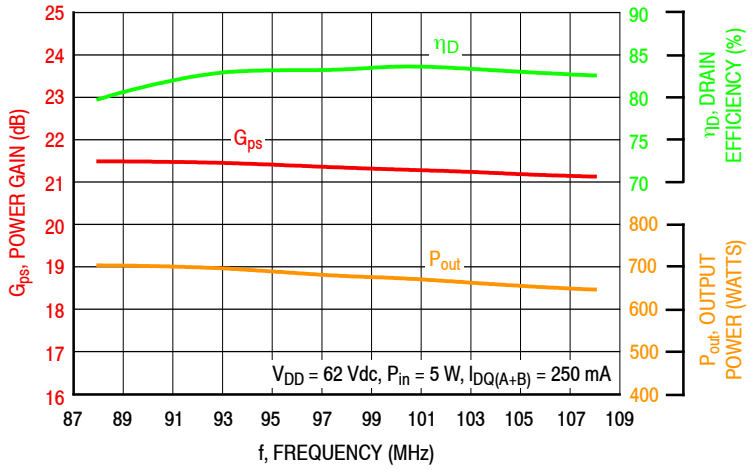


Figure 5. Power Gain, Drain Efficiency and CW Output Power versus Frequency at a Constant Input Power

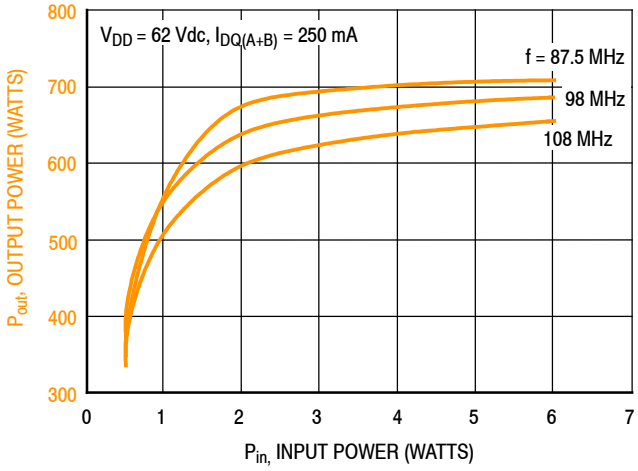


Figure 6. CW Output Power versus Input Power and Frequency

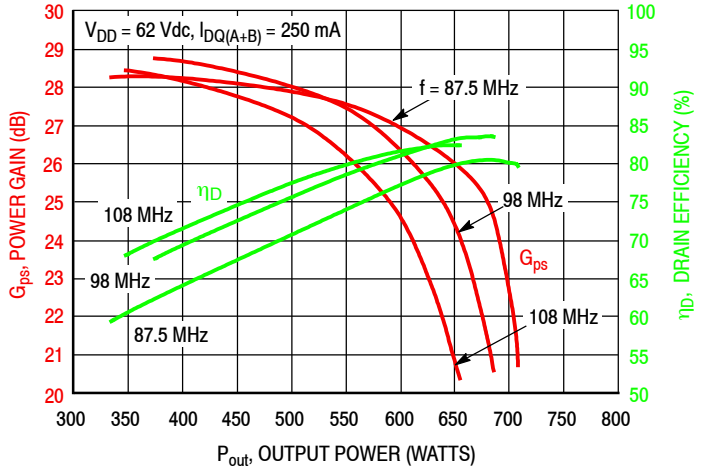


Figure 7. Power Gain and Drain Efficiency versus CW Output Power and Frequency

87.5–108 MHz BROADBAND REFERENCE CIRCUIT

f MHz	Z_{source} Ω	Z_{load} Ω
87.5	5.46 + j12.00	11.09 + j8.82
98	6.45 + j11.40	11.51 + j8.88
108	5.57 + j11.13	11.84 + j9.06

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

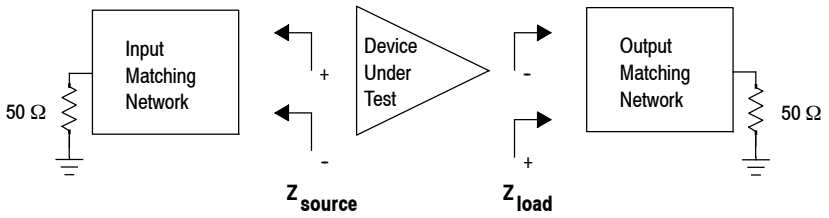
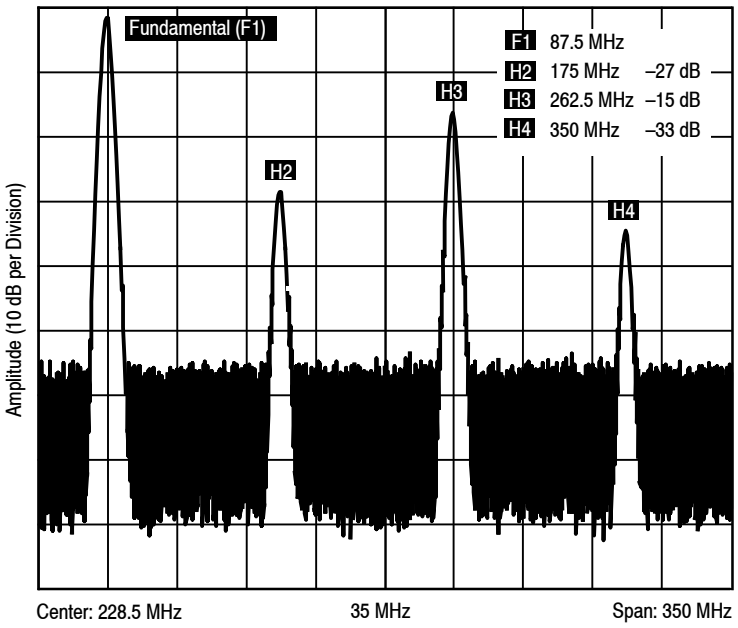


Figure 8. Broadband Series Equivalent Source and Load Impedance – 87.5–108 MHz

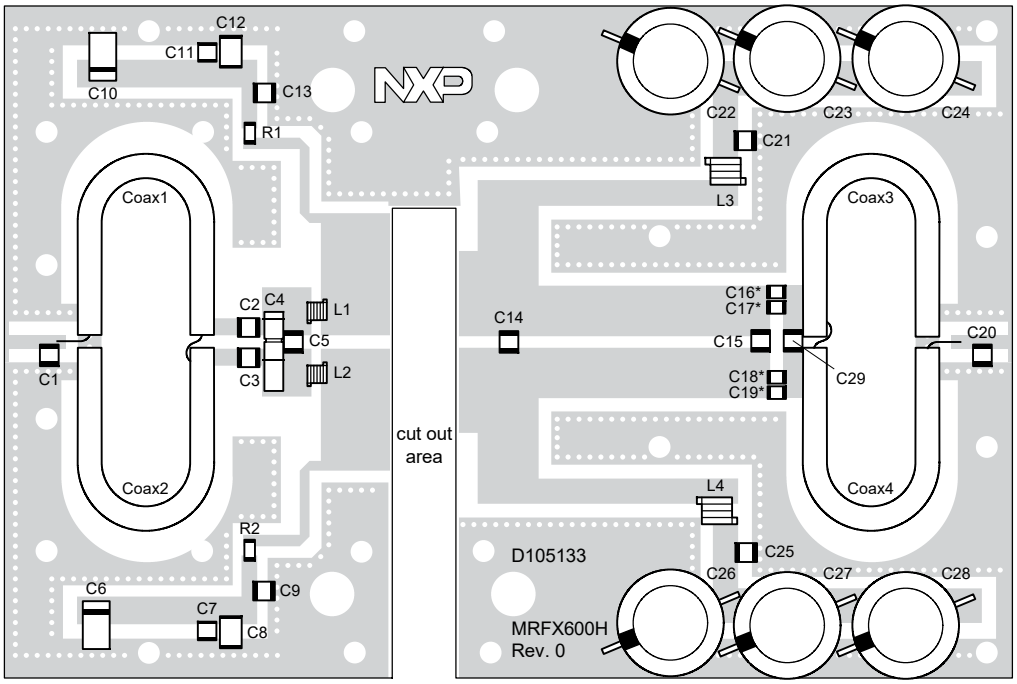
HARMONIC MEASUREMENTS — 87.5–108 MHz
BROADBAND REFERENCE CIRCUIT



H2 (175 MHz)	H3 (262.5 MHz)	H4 (350 MHz)
–27 dB	–15 dB	–33 dB

Figure 9. 87.5 MHz Harmonics @ 675 W CW

230 MHz PRODUCTION TEST FIXTURE — 4.0″ × 6.0″ (10.2 cm × 12.7 cm)



*C16, C17, C18 and C19 are mounted vertically.

Figure 10. MRFX600H Production Test Fixture Component Layout — 230 MHz

Table 9. MRFX600H Production Test Fixture Component Designations and Values — 230 MHz

Part	Description	Part Number	Manufacturer
C1	13 pF Chip Capacitor	ATC100B130JT500XT	ATC
C2, C3	27 pF Chip Capacitor	ATC100B270JT500XT	ATC
C4	0.8–8.0 pF Variable Capacitor	27291SL	Johanson Components
C5	33 pF Chip Capacitor	ATC100B330JT500XT	ATC
C6, C10	22 μF, 35 V Tantalum Capacitor	T491X226K035AT	Kemet
C7, C11	0.1 μF Chip Capacitor	CDR33BX104AKWS	AVX
C8, C12	220 nF Chip Capacitor	C1812C224K5RACTU	Kemet
C9, C13, C21, C25	1000 pF Chip Capacitor	ATC100B102JT50XT	ATC
C14, C29	39 pF Chip Capacitor	ATC100B390JT500XT	ATC
C15	43 pF Chip Capacitor	ATC100B430JT500XT	ATC
C16, C17, C18, C19	240 pF Chip Capacitor	ATC100B241JT200XT	ATC
C20	9.1 pF Chip Capacitor	ATC100B9R1BT500XT	ATC
C22, C23, C24, C26, C27, C28	470 μF, 100 V Electrolytic Capacitor	MCGPR100V477M16X32	Multicomp
Coax1, 2, 3, 4	25 Ω Semi-rigid Coax, 2.2″ Shield Length	UT-141C-25	Micro-Coax
L1, L2	5 nH Inductor	A02TKLC	Coilcraft
L3, L4	6.6 nH Inductor	GA3093-ALC	Coilcraft
R1, R2	10 Ω, 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
PCB	Rogers AD255C, 0.030″, ε_r = 2.55, 1 oz. Copper	D105133	MTL

TYPICAL CHARACTERISTICS — 230 MHz, T_C = 25°C
PRODUCTION TEST FIXTURE

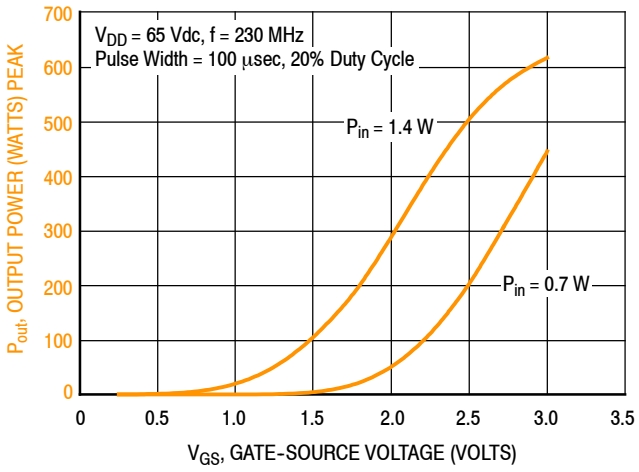
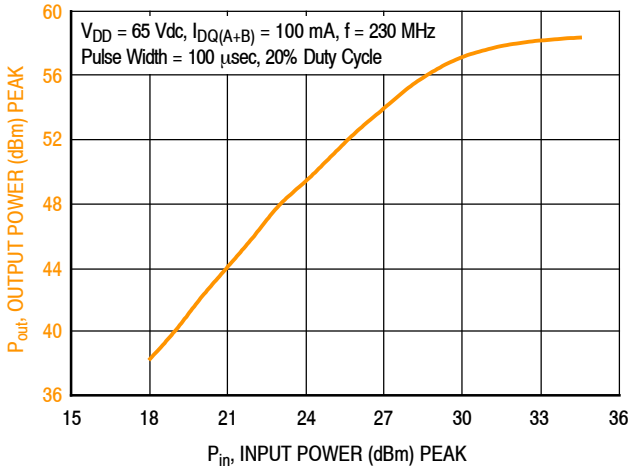


Figure 11. Output Power versus Gate-Source Voltage at a Constant Input Power



f (MHz)	P1dB (W)	P3dB (W)
230	610	677

Figure 12. Output Power versus Input Power

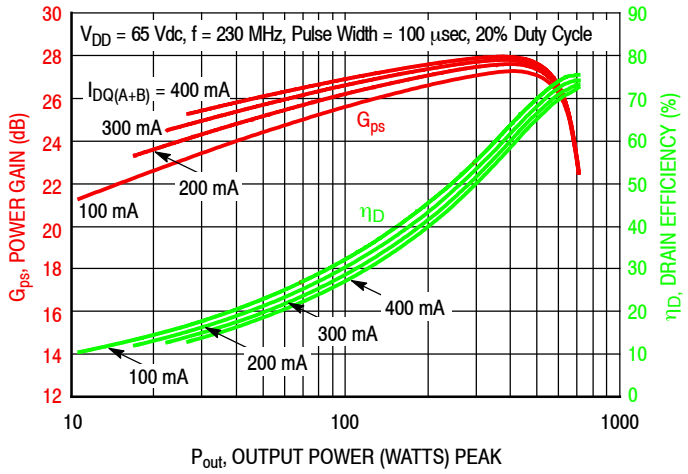


Figure 13. Power Gain and Drain Efficiency versus Output Power and Quiescent Current

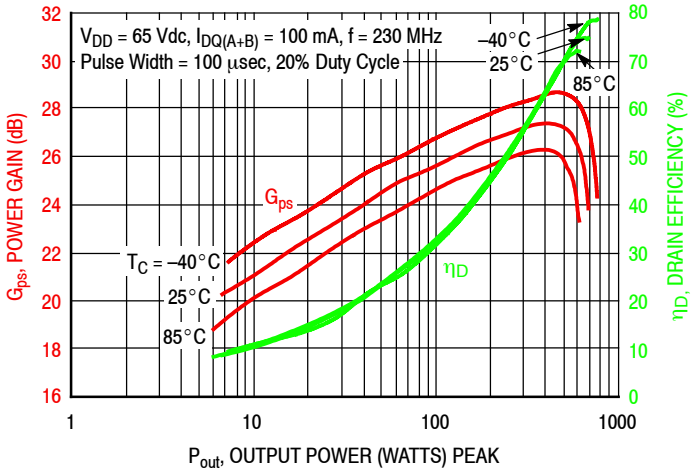


Figure 14. Power Gain and Drain Efficiency versus Output Power

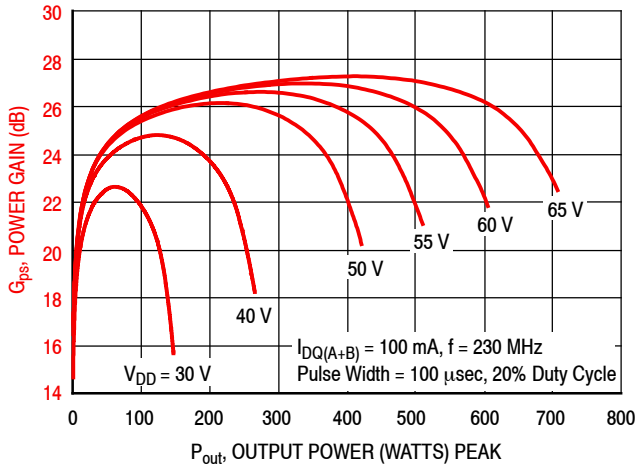


Figure 15. Power Gain versus Output Power and Drain-Source Voltage

230 MHz PRODUCTION TEST FIXTURE

f MHz	Z_{source} Ω	Z_{load} Ω
230	1.5 + j4.9	5.0 + j7.1

Z_{source} = Test fixture impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test fixture impedance as measured from drain to drain, balanced configuration.

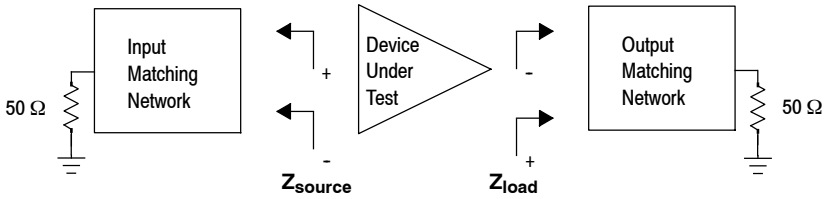
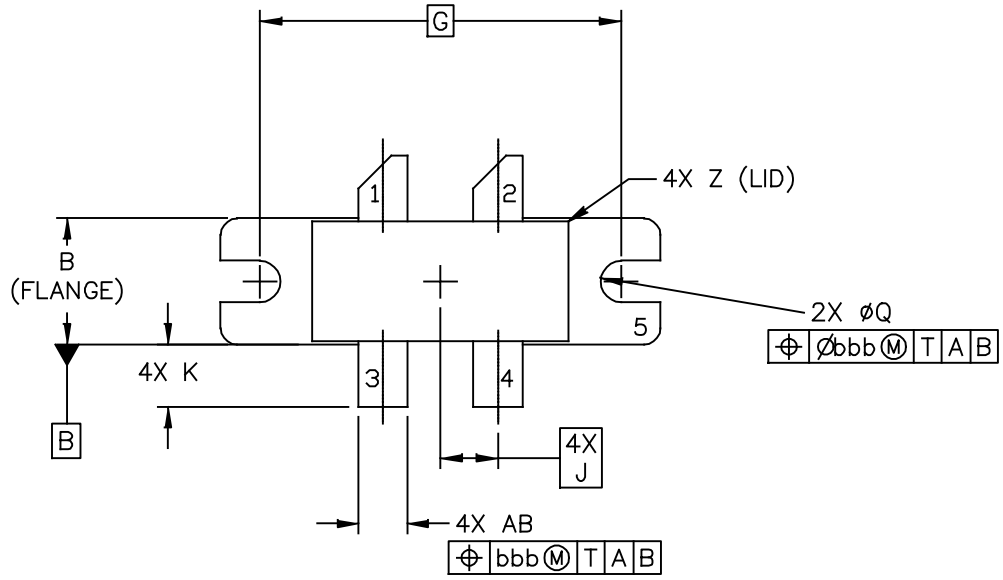
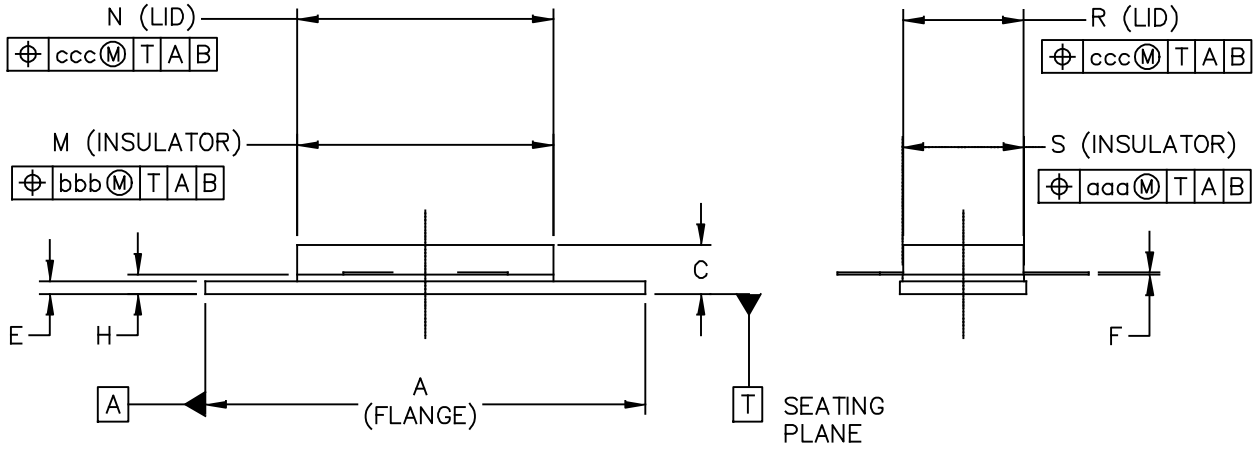


Figure 16. Series Equivalent Source and Load Impedance – 230 MHz

PACKAGE DIMENSIONS





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TITLE: NI 780–4	DOCUMENT NO: 98ASA10793D	REV: A
	STANDARD: NON–JEDEC	
	SOT1827–1	17 MAR 2016

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M–1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:
PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	1.335	1.345	33.91	34.16	R	.365	.375	9.27	9.53
B	.380	.390	9.65	9.91	S	.365	.375	9.27	9.52
C	.125	.170	3.18	4.32	U		.040		1.02
E	.035	.045	0.89	1.14	Z		.030		0.76
F	.003	.006	0.08	0.15	AB	.145	.155	3.68	3.94
G	1.100 BSC		27.94 BSC						
H	.057	.067	1.45	1.7	aaa		.005		0.127
J	.175 BSC		4.44 BSC		bbb		.010		0.254
K	.170	.210	4.32	5.33	ccc		.015		0.381
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
Q	ø.118	ø.138	ø3	ø3.51					

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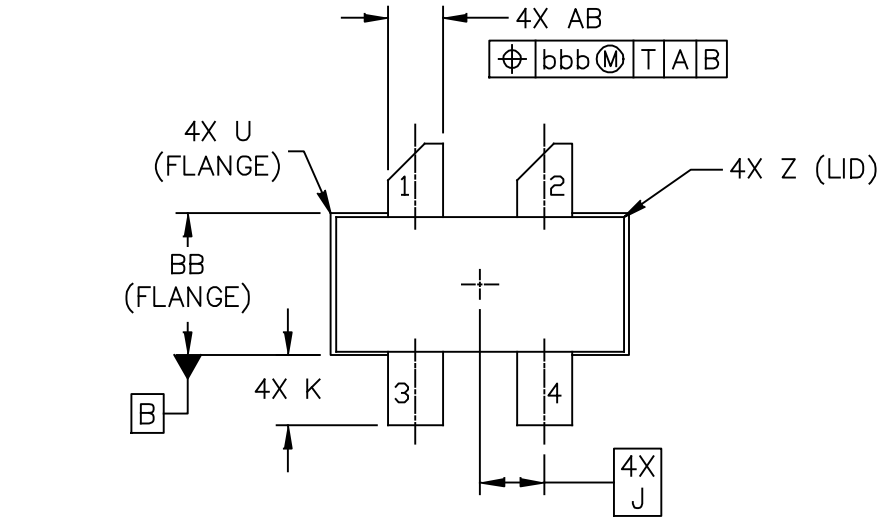
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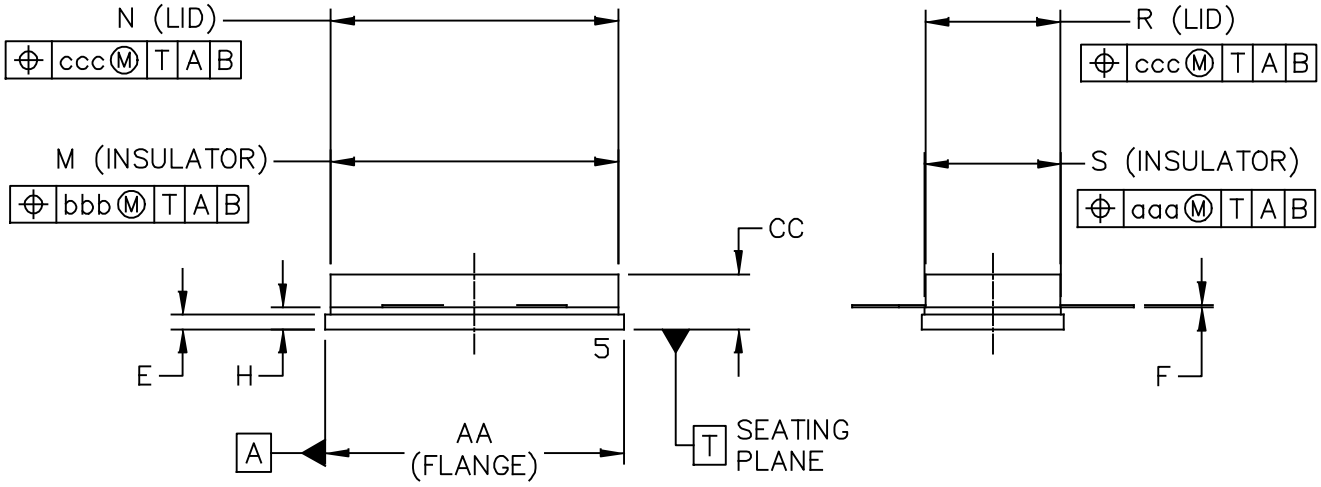
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DOCUMENT NO: 98ASA10793D REV: A

STANDARD: NON–JEDEC

SOT1827–1 17 MAR 2016





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	STANDARD: NON–JEDEC	
	SOT1826–1	01 AUG 2016

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M–1994.
2. CONTROLLING DIMENSION: INCH.
3. DELETED
4. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM FLANGE TO CLEAR EPOXY FLOW OUT PARALLEL TO DATUM B.

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
AA	.805	.815	20.45	20.70	U		.040		1.02
BB	.382	.388	9.70	9.86	Z		.030		0.76
CC	.125	.170	3.18	4.32	AB	.145	.155	3.68	3.94
E	.035	.045	0.89	1.14					
F	.003	.006	0.08	0.15	aaa		.005		0.127
H	.057	.067	1.45	1.70	bbb		.010		0.254
J	.175 BSC		4.44 BSC		ccc		.015		0.381
K	.170	.210	4.32	5.33					
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
R	.365	.375	9.27	9.53					
S	.365	.375	9.27	9.52					

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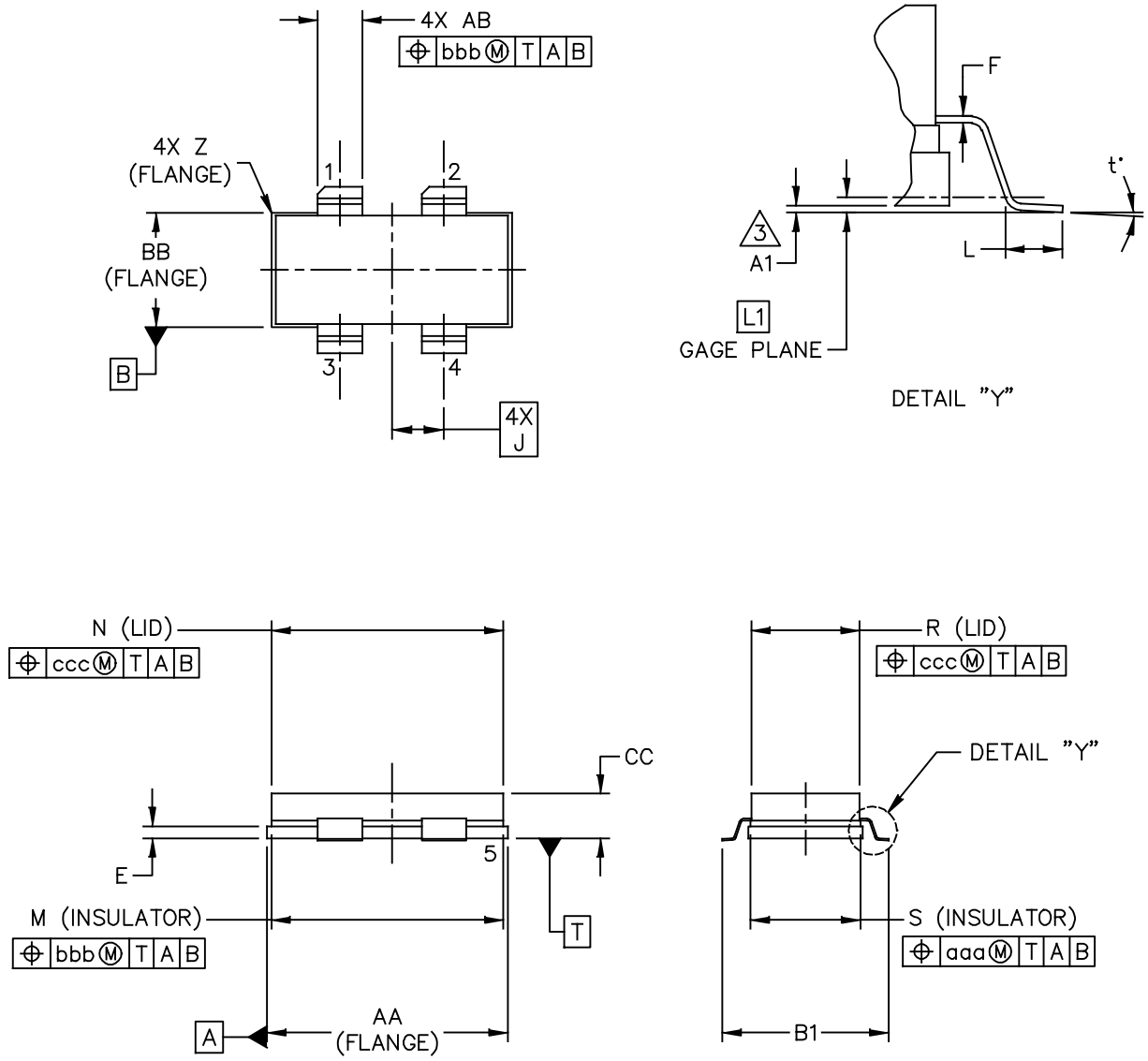
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	SOT1805−1	23 FEB 2016

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M–1994.

2. CONTROLLING DIMENSION: INCH.

3. DIMENSION A1 IS MEASURED WITH REFERENCE TO DATUM T. THE POSITIVE VALUE IMPLIES THAT THE PACKAGE BOTTOM IS HIGHER THAN THE LEAD BOTTOM.

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
AA	.805	.815	20.45	20.70	Z	R.000	R.040	R0.00	R1.02
A1	.002	.008	0.05	0.20	AB	.145	.155	3.68	3.94
BB	.380	.390	9.65	9.91	t°	0°	8°	0°	8°
B1	.546	.562	13.87	14.27	aaa		.005		0.13
CC	.125	.170	3.18	4.32	bbb		.010		0.25
E	.035	.045	0.89	1.14	ccc		.015		0.38
F	.003	.006	0.08	0.15					
L	.038	.046	0.97	1.17					
L1	.010 BSC		0.25 BSC						
J	.175 BSC		4.44 BSC						
M	.774	.786	19.66	19.96					
N	.772	.788	19.61	20.02					
R	.365	.375	9.27	9.53					
S	.365	.375	9.27	9.53					

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MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE

TITLE:

NI–780GS–4L

DOCUMENT NO: 98ASA00238D REV: C

STANDARD: NON–JEDEC

SOT1805–1 23 FEB 2016

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

- Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

1. Go to http://www.nxp.com/RF
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Sept. 2018	• Initial release of data sheet

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Document Number: MRFX600H
Rev. 0, 09/2018

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